


Search Notes 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/781,729		FUKAWATASE ET AL.	
	Examiner		Art Unit	
	David Dunn		3616	

SEARCHED			
Class	Subclass	Date	Examiner
280	751 752 753	3/2/2006	DD
188	300	9/8/06	DD
updated above		↓	↓

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference text		9/8/06	DD
search; see			
enclosed			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST text search; see enclosed.	3/2/2006	DD